

NAND GATES: 4011 QUAD 2 INPUT 4012 DUAL 4 INPUT 4023 TRIPLE 3 INPUT

GENERAL DESCRIPTION

These NAND gates are monolithic complementary MOS (CMOS) integrated circuits. The N and P channel enhancement mode transistors provide a symmetrical circuit with output swings essentially equal to the supply voltage. This results in high noise immunity over a wide supply voltage range. No DC power other than that caused by leakage current is consumed during static conditions. All inputs are protected against static discharge and latching conditions.

The MMC 4011, MMC 4012 and MMC 4023E/F/G/H NAND gates provide the system designer with direct implementation of the NAND function. All inputs and outputs are buffered.

The MMC 4011, MMC 4012 and MMC 4023E/F/G/H types are supplied in 14-lead hermetic dual-in-line ceramic or plastic packages.

FEATURES

- Propagation delay time = 60 ns (typ.) at $C_L = 50$ pF, $V_{DD} = 10$ V
- Buffered inputs and outputs
- 5 V, 10 V and 15 V parametric ratings
- 100% tested quiescent current
- High noise immunity $0.45 V_{DD}$ (typical)

APPLICATIONS

- Automotive
- Data terminals
- Instrumentation
- Medical electronics
- Alarm system
- Industrial controls
- Remote metering
- Computers

ABSOLUTE MAXIMUM RATINGS

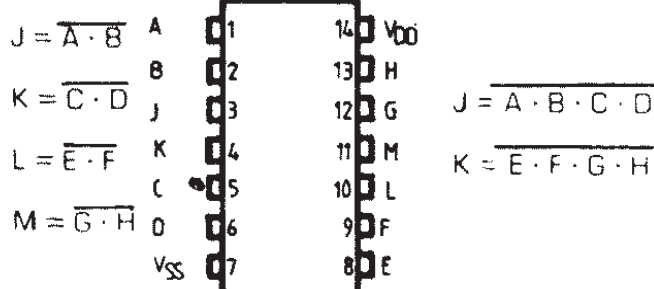
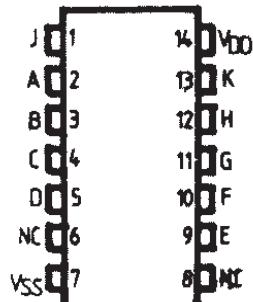
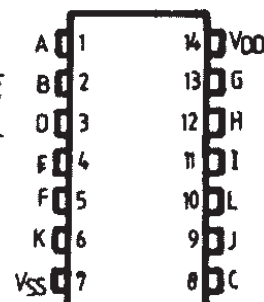
V_{DD}^*	Supply voltage: G and H types E and F types	-0.5 to 20 -0.5 to 18	V V
V_i	Input voltage	-0.5 to $V_{DD}+0.5$	V
I_i	DC input current (any one input)	± 10	mA
P_{tot}	Total power dissipation (per package) Dissipation per output transistor for $T_{op} =$ full package-temperature range	200	mW mW
T_A	Operating temperature: G and H types E and F types	-55 to 125 -40 to 85	$^{\circ}C$ $^{\circ}C$
T_{stg}	Storage temperature	-65 to 150	$^{\circ}C$

* All voltages are referred to V_{SS} pin voltage

RECOMMENDED OPERATING CONDITIONS

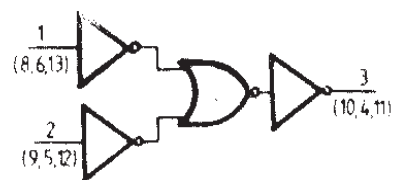
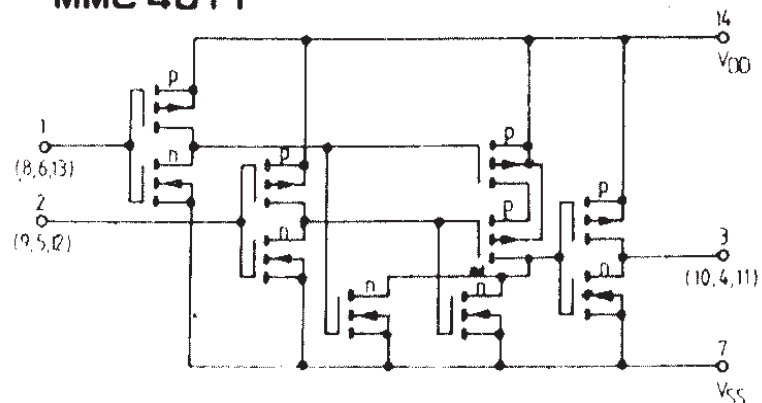
V_{DD}^*	Supply voltage: G and H types E and F types	3 to 18 3 to 15	V V
V_i	Input voltage	0 to V_{DD}	V
T_A	Operating temperature: G and H types E and F types	-55 to 125 40 to 95	$^{\circ}C$ $^{\circ}C$

CONNECTION DIAGRAMS

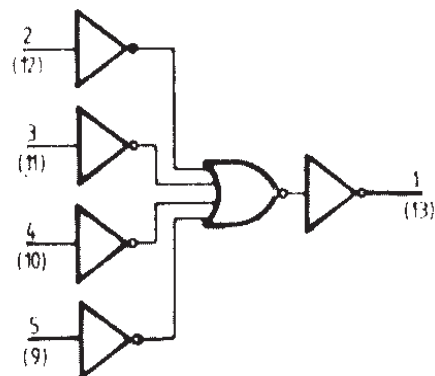
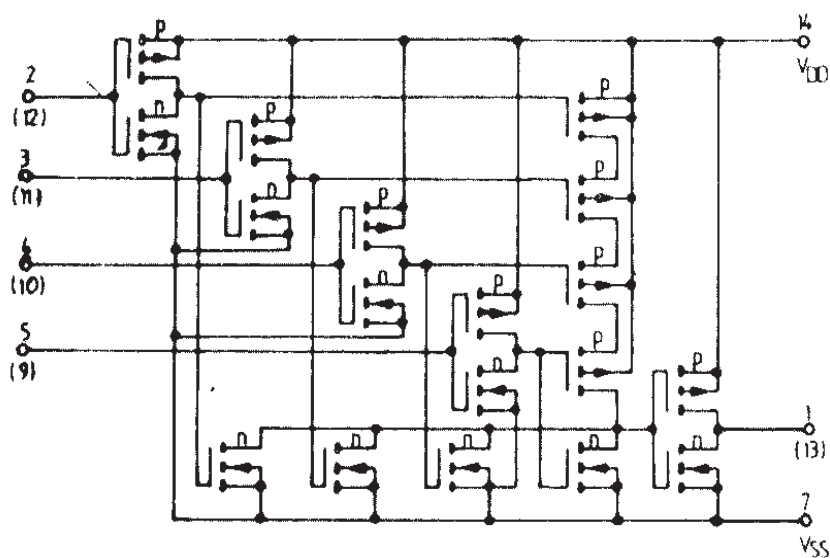
MMC 4011

MMC 4012

MMC 4023


SCHEMATIC AND LOGIC DIAGRAMS

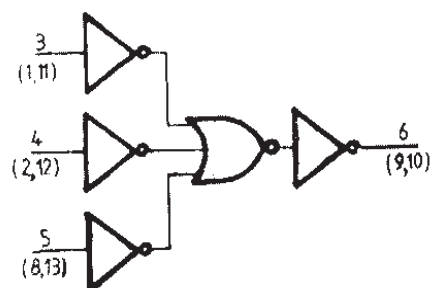
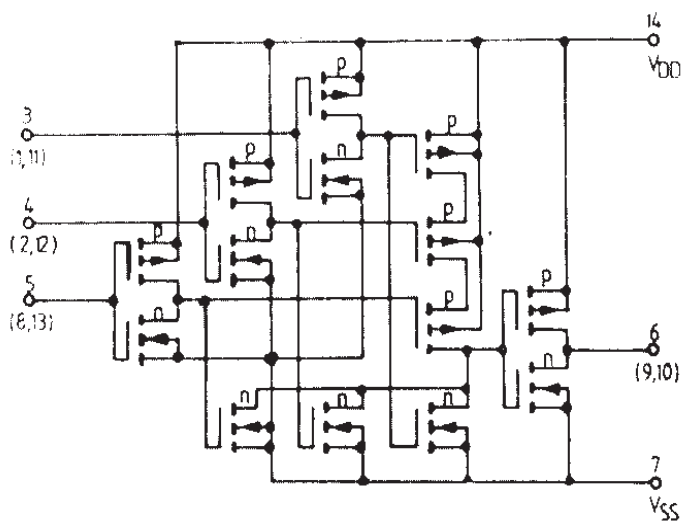
MMC 4011



MMC 4012



MMC 4023



STATIC ELECTRICAL CHARACTERISTICS

(over recommended operating conditions)

PARAMETER		TEST CONDITIONS				VALUES						UNI	
		V _I (V)	V _O (V)	I _O (μ A)	V _{DD} (V)	T _{LOW}		25°C			T _{HIGH}		
						min.	max.	min.	typ	max.	min.		max.
I _L Quiescent current	G, H types	0/5 0/10 0/15 0/20			5 10 15 20		0.25 0.5 1 5		0.01 0.01 0.01 0.02	0.25 0.5 1 5		7.5 15 30 150	μ A
	E, F types	0/5 0/10 0/15			5 10 15		1 2 4		0.01 0.01 0.01	1 2 4		7.5 15 30	
V _{OH} Output high voltage		0/5 0/10 0/15		< 1 < 1 < 1	5 10 15	4.95 9.95 14.95		4.95 9.95 14.95			4.95 9.95 14.95		V
V _{OL} Output low voltage		5/0 10/0 15/0		< 1 < 1 < 1	5 10 15		0.05 0.05 0.05			0.05 0.05 0.05		0.05 0.05 0.05	V
V _{IH} Input high voltage			0.5/4.5 1/9 1.5/13.5	< 1 < 1 < 1	5 10 15	3.5 7 11		3.5 7 11			3.5 7 11		V
V _{IL} Input low voltage			4.5/0.5 9/1 13.5/1.5	< 1 < 1 < 1	5 10 15		1.5 3 4			1.5 3 4		1.5 3 4	V
I _{OH} Output drive current	G, H types	0/5 0/5 0/10 0/15	2.5 4.6 9.5 13.5		5 5 10 15	-2 -0.64 -1.6 -4.2		-1.6 -0.51 -1.3 -3.4	-3.2 -1 -2.6 -6.8		-1.15 -0.36 -0.9 -2.4		mA
	E, F types	0/5 0/5 0/10 0/15	2.5 4.6 9.5 13.5		5 5 10 15	-1.53 -0.52 -1.3 -3.6		-1.36 -0.44 -1.1 -3.0	-3.2 -1 -2.6 -6.8		-1.1 -0.36 -0.9 -2.4		
I _{OL} Output sink current	G, H types	0/5 0/10 0/15	0.4 0.5 1.5		5 10 15	0.64 1.6 4.2		0.51 1.3 3.4	1 2.6 6.8		0.36 0.9 2.4		mA
	E, F types	0/5 0/10 0/15	0.4 0.5 1.5		5 10 15	0.52 1.3 3.6		0.44 1.1 3.0	1 2.6 6.8		0.36 0.9 2.4		
I _{IH} , I _{IL} Input leakage current	G, H types	0/18	Any input		18		± 0.1		$\pm 10^{-5}$	± 0.1		± 1	μ A
	E, F types	0/15			15		± 0.3		$\pm 10^{-5}$	± 0.3		± 1	
C _i Input capacitance			Any input						5	7.5			pF

T_{LOW} = -55°C for G, H devices; 40°C for E, F devices.

T_{HIGH} = +125°C for G, H devices; +85°C for E, F devices.

The Noise Margin for both "1" and "0" level is:

- 1 V min. with V_{DD} = 5 V
- 2 V min. with V_{DD} = 10 V
- 2.5 V min. with V_{DD} = 15 V

DYNAMIC ELECTRICAL CHARACTERISTICS

($T_A = 25^\circ\text{C}$, $C_L = 50\text{ pF}$, $R_L = 200\text{ k}$, typical temperature coefficient for all V_{DD} values is $0.3\%/^\circ\text{C}$, all input rise and fall times = 20 ns)

PARAMETER	TEST CONDITIONS	VALUES			UNIT
	V_{DD} (V)	min	typ	max	
t_{PLH} Propagation delay time t_{PHL}	5		125	250	ns
	10		60	120	
	15		45	90	
t_{THL} Transition time t_{TLH}	5		100	200	ns
	10		50	100	
	15		40	80	